

<b>Search Notes</b>  <b>*1055364</b> <b>8*</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10553648	ZHANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Miller, Brandon J	2617

### SEARCHED

Class	Subclass	Date	Examiner
370	338,328	12/13/10	BJM
455	410-411,41.2,426.1,432.1,435.1	12/13/10	BJM

### SEARCH NOTES

Search Notes	Date	Examiner
East (US-PGPUB, USPAT, Derwent, JPO, EPO)	12/13/10	BJM
East-Text - keyword and keyword/cl.(see search history)	12/13/10	BJM
Inventor Search. Double patenting checked.	12/13/10	BJM

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner